



Supporting Information

for

A set of empirical equations describing the observed colours of metal–anodic aluminium oxide–Al nanostructures

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Additional experimental data

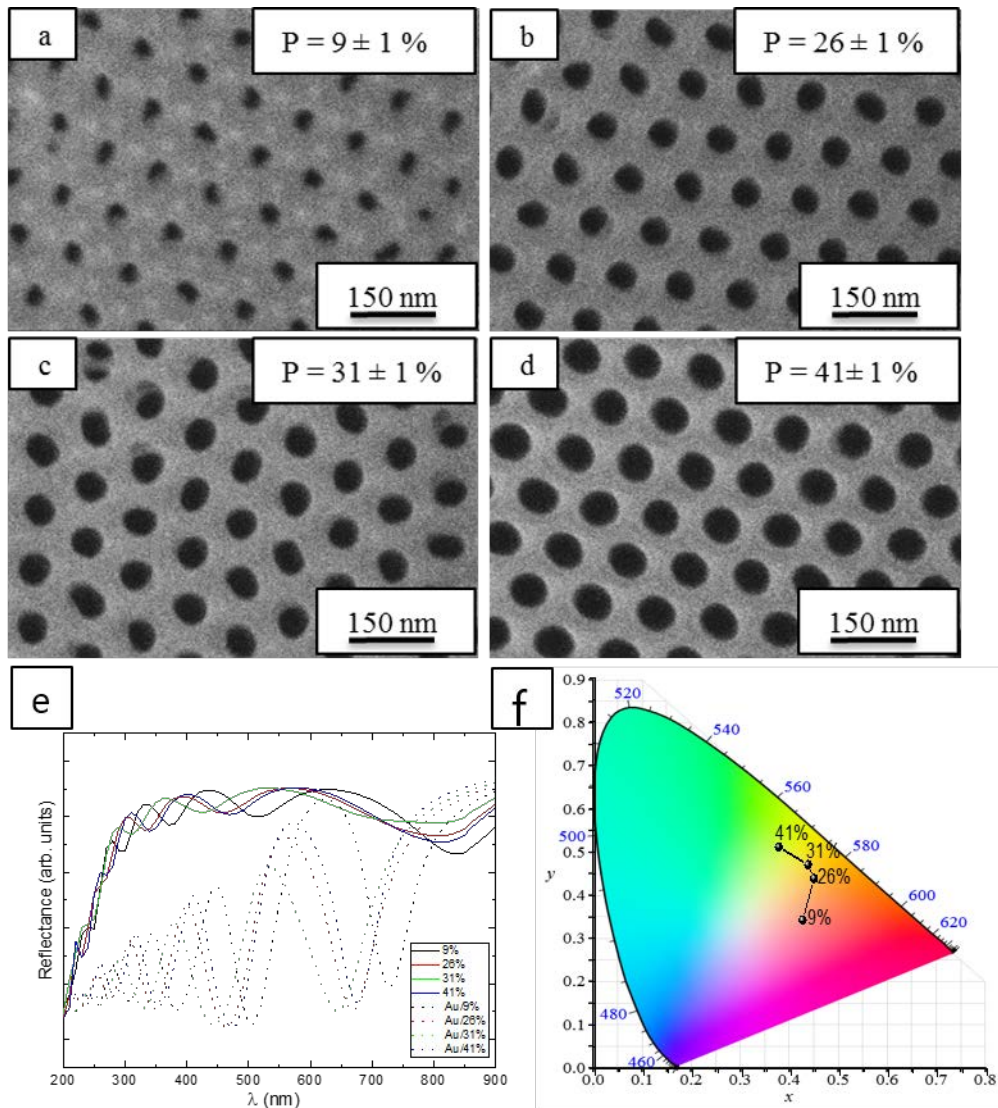


Figure S1: FE-SEM micrographs of AAO films anodized in 0.3 M oxalic acid under 40 V at 3 °C with different porosity after different periods of chemical etching time: (a) 2 min, (b) 4 min, (c) 6 min, and (d) 8 min. (e) UV-vis reflectance spectra of AAO-Al films with different porosity before (continuous lines) and after (dotted lines) deposition of 25 nm Au. (f) Colour diagram of 25 nm Au-AAO-Al films with different porosity.

Equations for transforming Cartesian coordinates (x,y) to polar coordinates (R, θ) :

$$R = \sqrt{(x - x_m)^2 + (y - y_m)^2} \quad (S1)$$

$$\theta = \arctan\left(\frac{y - y_m}{x - x_m}\right)$$

where \arctan is:

$$\arctan(y,x) = \begin{pmatrix} \arctan\left(\frac{y}{x}\right) \text{ if } x > 0 \\ \arctan\left(\frac{y}{x}\right) + \pi \text{ if } x < 0 \text{ and } y \geq 0 \\ \arctan\left(\frac{y}{x}\right) - \pi \text{ if } x < 0 \text{ and } y < 0 \\ \frac{\pi}{2} \text{ if } x = 0 \text{ and } y > 0 \\ -\frac{\pi}{2} \text{ if } x = 0 \text{ and } y < 0 \\ \text{undefined if } x = 0 \text{ and } y = 0 \end{pmatrix} \quad (S2)$$

The equations obtained for 10 nm Au-AAO-Al nanostructures are:

$$x_{\text{Au},209-332\text{nm}}(\theta) = R(\theta) \cdot \cos \theta + 0.3483, \quad (S3)$$

$$y_{\text{Au},209-332\text{nm}}(\theta) = R(\theta) \cdot \sin \theta + 0.4145,$$

where $\theta_{\text{Au},209-332\text{nm}}(d) = -(0.35 \pm 0.04) \cdot 10^{-1} \cdot d + (9.14 \pm 1.20)$ with $R^2 = 0.92$

and $R(\theta) = -(0.27 \pm 0.58) \cdot 10^{-2} \cdot \theta + (0.11 \pm 0.01)$ for $209 \text{ nm} < d < 332 \text{ nm}$,

and

$$x_{\text{Au},333-380\text{nm}} = R(\theta) \cdot \cos \theta + 0.3140, \quad (S4)$$

$$y_{\text{Au},333-380\text{nm}} = R(\theta) \cdot \sin \theta + 0.4872,$$

where $\theta_{\text{Au},333-380\text{nm}}(d) = (0.66 \pm 0.25) \cdot 10^{-1} \cdot d - (23.76 \pm 8.80)$ with $R^2 = 0.77$

and $R(\theta) = (9.31 \pm 0.90) \cdot 10^{-2} \cdot \theta + (0.29 \pm 0.17) \cdot 10^{-1}$ for $333 \text{ nm} < d < 380 \text{ nm}$.

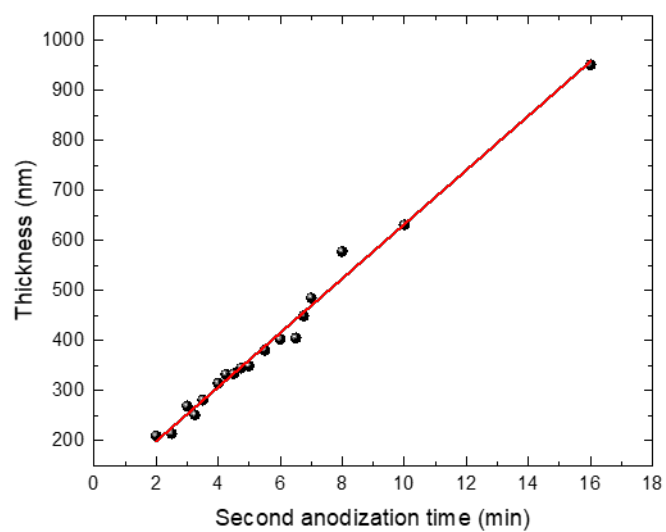


Figure S2: Thickness as a function of the second anodization time for AAO films anodized in an aqueous solution of 0.3M oxalic acid under 40 V at 3 °C.

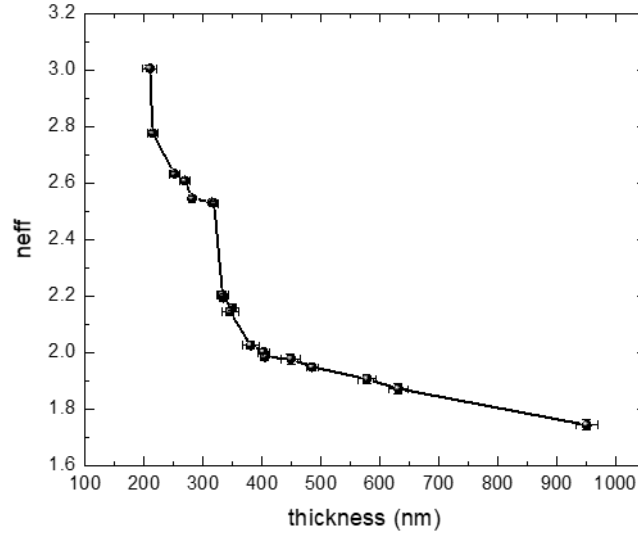


Figure S3: Effective refractive index as a function of the thickness of AAO films anodized in an aqueous solution of 0.3M oxalic acid under 40 V at 3 °C.

The equations for 8 nm Cr–AAO–Al nanostructures can now be written as a function of the effective refractive index and the second anodization time. The value of θ as a function of the effective refractive index (n_{eff}) is:

$$\theta_{Cr,209-332nm}(n_{eff}) = -0.36 \cdot 10^{-1} \cdot \left[(-183.84 \pm 52.50) \cdot \ln \left[\frac{n_{eff} - (1.64 \pm 0.19)}{4.12 \pm 1.07} \right] \right] + 8.75$$

for $209 \text{ nm} < d < 332 \text{ nm}$, and (S5)

$$\theta_{Cr,333-380nm}(n_{eff}) = -0.74 \cdot 10^{-1} \cdot \left[(-183.84 \pm 52.50) \cdot \ln \left[\frac{n_{eff} - (1.64 \pm 0.19)}{4.12 \pm 1.07} \right] \right] + 27.71$$

for $333 \text{ nm} < d < 380 \text{ nm}$.

The value of θ as a function of the second anodization time, t^{2nd} , is:

$$\theta_{Cr,209-332nm}(t^{2nd}) = -0.36 \cdot 10^{-1} \cdot [(54.23 \pm 1.43) \cdot t^{2nd} + (90.03 \pm 9.31)] + 8.75$$

for $209 \text{ nm} < d < 332 \text{ nm}$, and (S6)

$$\theta_{Cr,333-380nm}(t^{2nd}) = -0.74 \cdot 10^{-1} \cdot [(54.23 \pm 1.43) \cdot t^{2nd} + (90.03 \pm 9.31)] + 27.71$$

for $333 \text{ nm} < d < 380 \text{ nm}$.

The equations for 10 nm Au–AAO–Al nanostructures can now be written as a function of the effective refractive index and the second anodization time. The value of θ as a function of the effective refractive index (n_{eff}) is:

$$\theta_{\text{Au},209-332\text{nm}}(n_{\text{eff}}) = -0.35 \cdot 10^{-1} \cdot \left[(-183.84 \pm 52.50) \cdot \ln \left[\frac{n_{\text{eff}} - (1.64 \pm 0.19)}{4.12 \pm 1.07} \right] \right] + 9.14$$

for $209 \text{ nm} < d < 332 \text{ nm}$, and (S7)

$$\theta_{\text{Au},333-380\text{nm}}(n_{\text{eff}}) = 0.66 \cdot 10^{-1} \cdot \left[(-183.84 \pm 52.50) \cdot \ln \left[\frac{n_{\text{eff}} - (1.64 \pm 0.19)}{4.12 \pm 1.07} \right] \right] - 23.76$$

for $333 \text{ nm} < d < 380 \text{ nm}$.

The value of θ as a function of the second anodization time, $t^{2\text{nd}}$, is:

$$\theta_{\text{Au},209-332\text{nm}}(t^{2\text{nd}}) = -0.35 \cdot 10^{-1} \cdot [(54.23 \pm 1.43) \cdot t^{2\text{nd}} + (90.03 \pm 9.31)] + 9.14$$

for $209 \text{ nm} < d < 332 \text{ nm}$, and (S8)

$$\theta_{\text{Au},333-380\text{nm}}(t^{2\text{nd}}) = 0.66 \cdot 10^{-1} \cdot [(54.23 \pm 1.43) \cdot t^{2\text{nd}} + (90.03 \pm 9.31)] - 23.76$$

for $333 \text{ nm} < d < 380 \text{ nm}$.

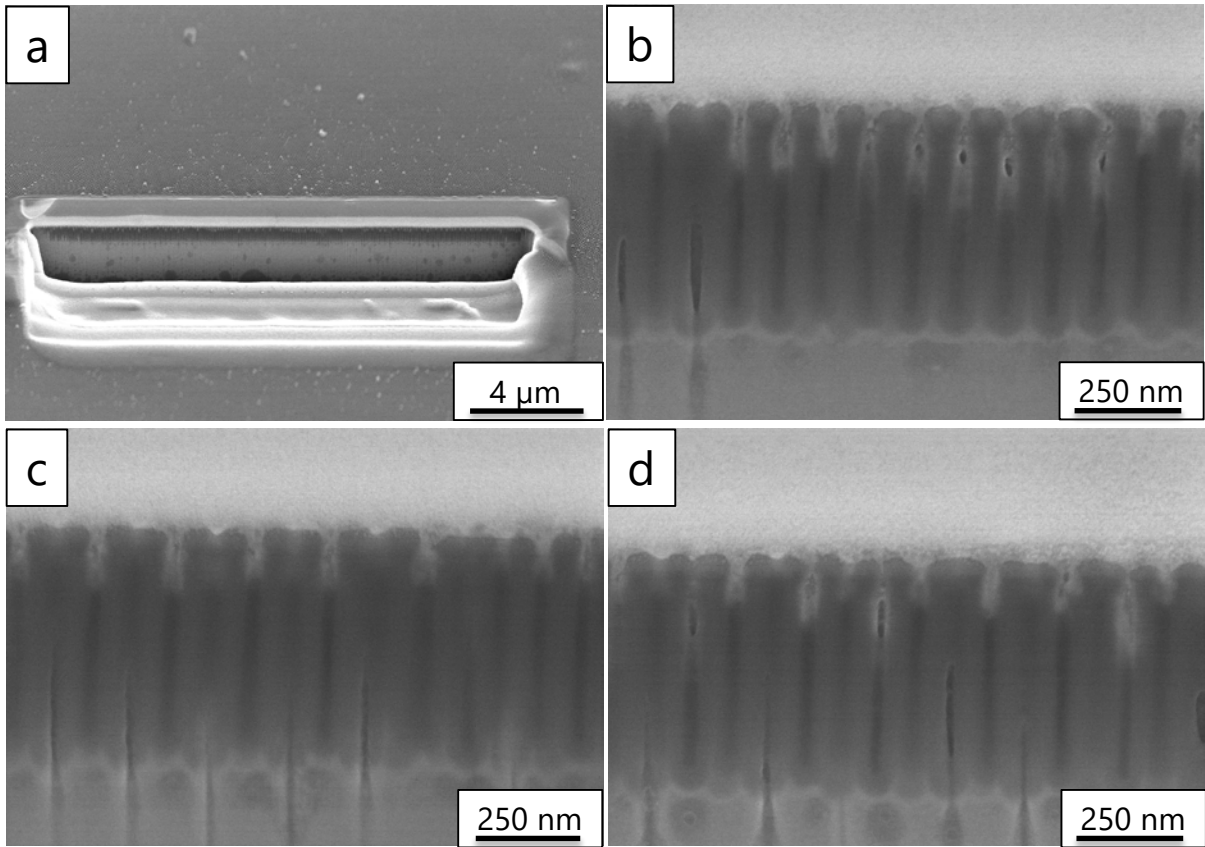


Figure S4: FE-SEM micrographs of AAO films: (a) cross section of an AAO film after FIB cutting, (b–d) cross-sectional images of an AAO film after FIB cutting showing different parts of the sample.

Table S1: AAO thickness, x and y values obtained from the wavelength of the maximum reflectance, x and y values calculated from the reflectance measurements and x and y values calculated from the proposed model for 8 nm Cr-AAO-Al and 10 nm Au-AAO-Al nanostructures.

8 nm Cr-AAO-Al nanostructures							
thickness (nm)	λ_{\max} (nm)	$x_{\lambda_{\max}}$	$y_{\lambda_{\max}}$	$x_{\text{Reflectance}}$	$y_{\text{Reflectance}}$	x_{model}	y_{model}
209 ± 12	569	0.4788	0.5212	0.4115	0.4283	0.4086	0.4680
214 ± 10	671	0.6833	0.2608	0.5124	0.4170	0.4355	0.4580
251 ± 10	708	0.3958	0.1122	0.5155	0.3831	0.5230	0.2808
269 ± 10	700	0.7500	0.2500	0.4554	0.3175	0.4714	0.1930
281 ± 7	420	0.1765	0.0197	0.2572	0.1921	0.3601	0.1538
315 ± 5	450	0.1523	0.0367	0.2058	0.2065	0.2373	0.2192
318 ± 7	460	0.1402	0.0594	0.2037	0.2511	0.2279	0.2336
333 ± 10	530	0.2076	0.7661	0.3460	0.4745	0.3365	0.4782
349 ± 15	509	0.0499	0.8029	0.3350	0.4682	0.3432	0.4631
380 ± 15	540	0.2793	0.7111	0.3698	0.4833	0.3642	0.4778
10 nm Au-AAO-Al nanostructures							
thickness (nm)	λ_{\max} (nm)	$x_{\lambda_{\max}}$	$y_{\lambda_{\max}}$	$x_{\text{Reflectance}}$	$y_{\text{Reflectance}}$	x_{model}	y_{model}
209 ± 12	536	0.2789	0.7115	0.3886	0.4326	0.3877	0.4653
214 ± 10	645	0.7056	0.2944	0.4994	0.4590	0.4086	0.4682
251 ± 10	667	0.6381	0.2399	0.5100	0.4387	0.5284	0.3860
269 ± 10	681	0.7059	0.2941	0.5003	0.4078	0.5287	0.3113
281 ± 7	748	0.7500	0.2500	0.4254	0.2792	0.4741	0.2441
315 ± 5	458	0.1392	0.0591	0.3633	0.2392	0.3723	0.2360
318 ± 7	483	0.1149	0.1092	0.3334	0.2460	0.3607	0.2410
332 ± 7	509	0.1392	0.0591	0.2955	0.2932	0.3164	0.2792
333 ± 10	511	0.0723	0.2289	0.2995	0.4720	0.2870	0.4645
349 ± 15	507	0.0056	0.6751	0.3126	0.4808	0.3048	0.4564
380 ± 15	523	0.1259	0.8094	0.3299	0.5088	0.3145	0.4873